

RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

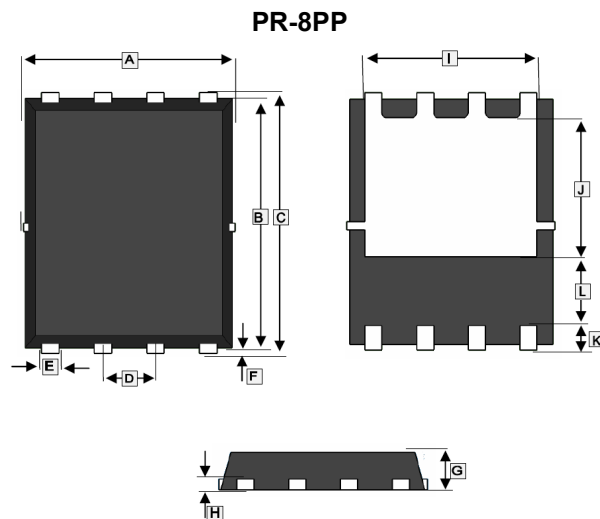
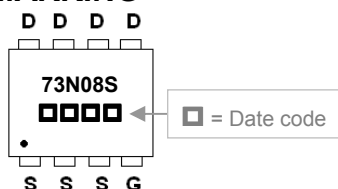
The SPR73N08S-C is the highest performance N-ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous rectification applications.

The SPR73N08S-C meet the RoHS and Green Product requirement with full function reliability approved.

FEATURES

- Green Device Available
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Advanced high cell density Trench technology

MARKING



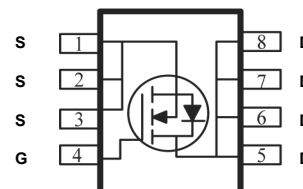
REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	4.9	5.1	G	0.8	1.0
B	5.7	5.9	H	0.254	Ref.
C	5.95	6.2	I	4.0	Ref.
D	1.27	BSC.	J	3.4	Ref.
E	0.35	0.49	K	0.6	Ref.
F	0.1	0.2	L	1.4	Ref.

PACKAGE INFORMATION

Package	MPQ	Leader Size
PR-8PP	3K	13 inch

ORDER INFORMATION

Part Number	Type
SPR73N08S-C	Lead (Pb)-free and Halogen-free



ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit	
Drain-Source Voltage	V_{DS}	80	V	
Gate-Source Voltage	V_{GS}	± 20	V	
Continuous Drain Current ¹ @ $V_{GS}=10\text{V}$	$T_C=25^\circ\text{C}$	73	A	
	$T_C=100^\circ\text{C}$	46		
Pulsed Drain Current ²	I_{DM}	160	A	
Total Power Dissipation ³	$T_C=25^\circ\text{C}$	P_D	56.8	W
Operating Junction & Storage Temperature Range	T_J, T_{STG}	-55~150	$^\circ\text{C}$	
Thermal Data				
Thermal Resistance Junction-Ambient ¹	$R_{\theta JA}$	62	$^\circ\text{C} / \text{W}$	
Thermal Resistance Junction-Case ¹	$R_{\theta JC}$	2.2		

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	80	-	-	V	$V_{GS}=0V, I_D=250\mu A$
Gate-Threshold Voltage	$V_{GS(th)}$	1	-	2.5	V	$V_{DS}=V_{GS}, I_D=250\mu A$
Forward Transfer conductance	g_{fs}	-	75	-	S	$V_{DS}=5V, I_D=20A$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Drain-Source Leakage Current	I_{DSS}	-	-	1	μA	$V_{DS}=64V, V_{GS}=0V, T_J=25^\circ\text{C}$
		-	-	5		$V_{DS}=64V, V_{GS}=0V, T_J=55^\circ\text{C}$
Static Drain-Source On-Resistance ²	$R_{DS(ON)}$	-	4.3	6.5	m Ω	$V_{GS}=10V, I_D=20A$
		-	6.3	8.5		$V_{GS}=4.5V, I_D=20A$
Total Gate Charge	Q_g	-	40	-	nC	$I_D=20A$ $V_{DS}=40V$ $V_{GS}=10V$
Gate-Source Charge	Q_{gs}	-	7.2	-		
Gate-Drain Change	Q_{gd}	-	6.5	-		
Turn-on Delay Time	$T_{d(on)}$	-	8.3	-	nS	$V_{DD}=40V$ $I_D=20A$ $V_{GS}=10V$ $R_G=3\Omega$
Rise Time	T_r	-	4.2	-		
Turn-off Delay Time	$T_{d(off)}$	-	36	-		
Fall Time	T_f	-	6.9	-		
Input Capacitance	C_{iss}	-	2860	-	pF	$V_{GS}=0V$ $V_{DS}=40V$ $f=1\text{MHz}$
Output Capacitance	C_{oss}	-	410	-		
Reverse Transfer Capacitance	C_{rss}	-	38	-		
Source-Drain Diode						
Diode Forward Voltage ²	V_{SD}	-	-	1.2	V	$I_S=1A, V_{GS}=0V, T_J=25^\circ\text{C}$
Continuous Source Current ¹	I_S	-	-	73	A	$V_G=V_D=0V, \text{Force Current}$
Reverse Recovery Time	t_{rr}	-	27	-	nS	$I_F=20A, dI/dt=100A/\mu s, T_J=25^\circ\text{C}$
Reverse Recovery Charge	Q_{rr}	-	89	-	nC	

Notes:

- The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- The data tested by pulsed pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
- The power dissipation is limited by 150°C junction temperature.

CHARACTERISTIC CURVES

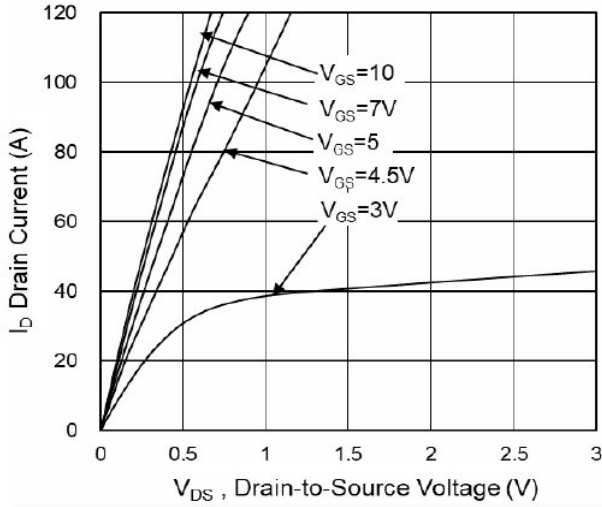


Fig.1 Typical Output Characteristics

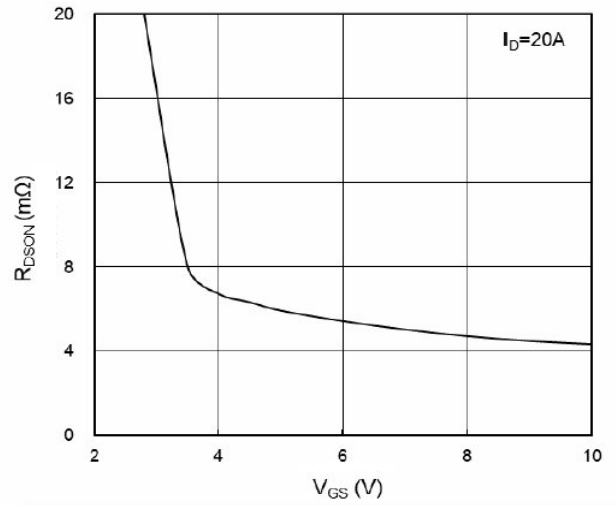


Fig.2 On-Resistance vs G-S Voltage

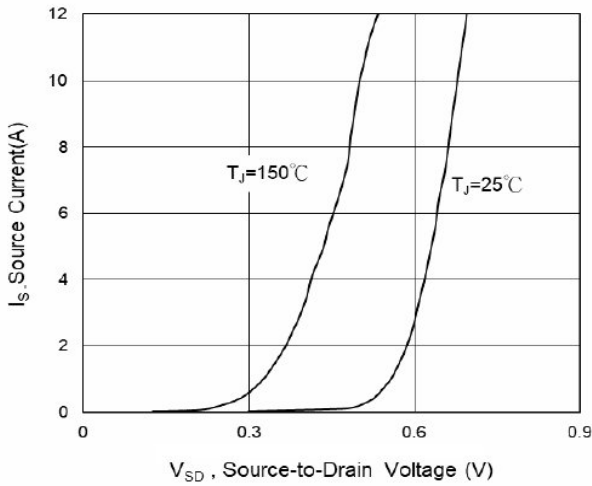


Fig.3 Source Drain Forward Characteristics

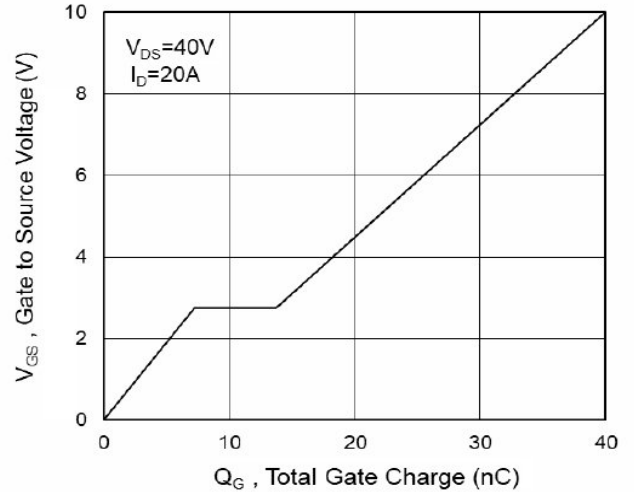


Fig.4 Gate-Charge Characteristics

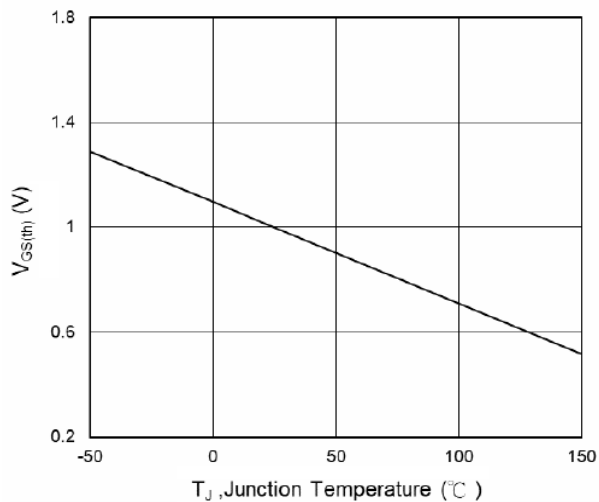


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

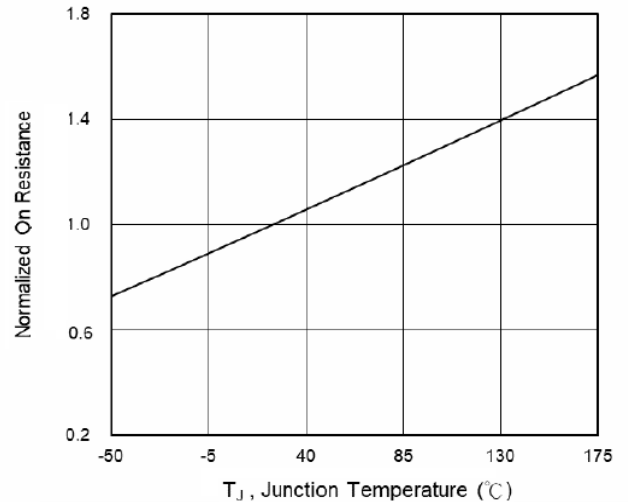


Fig.6 Normalized $R_{DS(ON)}$ vs. T_J

CHARACTERISTIC CURVES

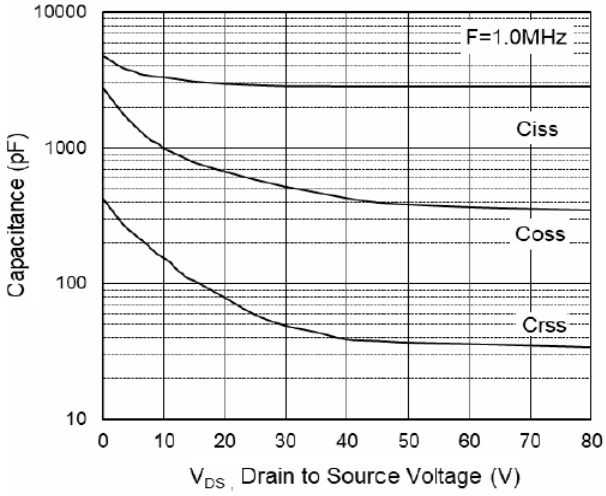


Fig.7 Capacitance

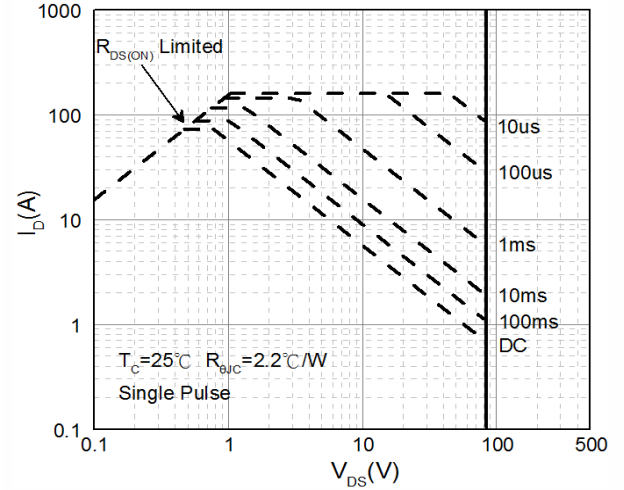


Fig.8 Safe Operating Area

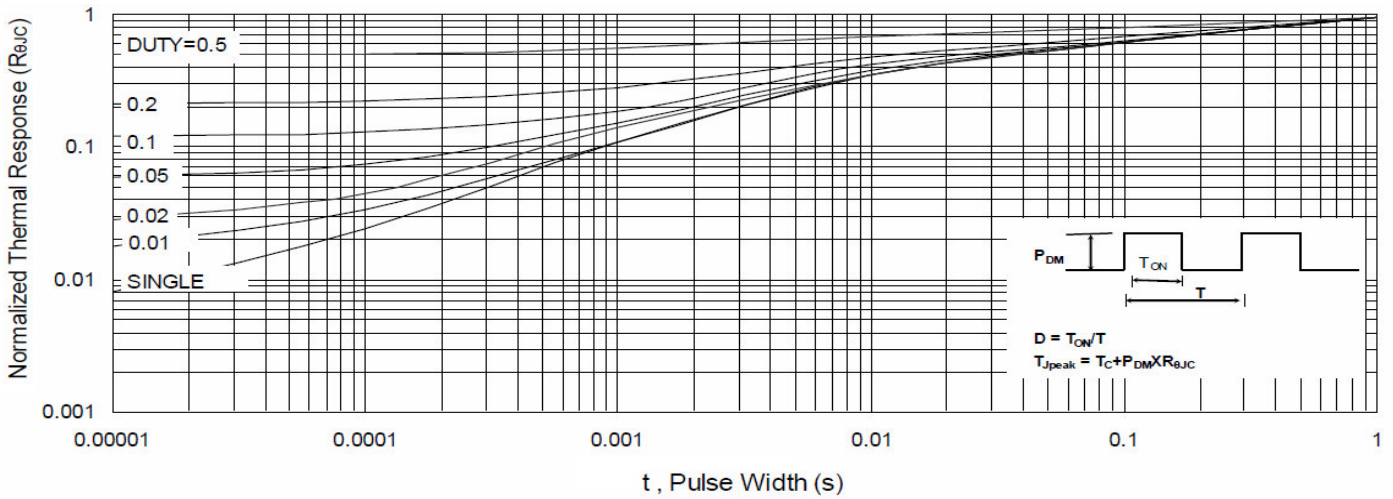


Fig.9 Normalized Maximum Transient Thermal Impedance

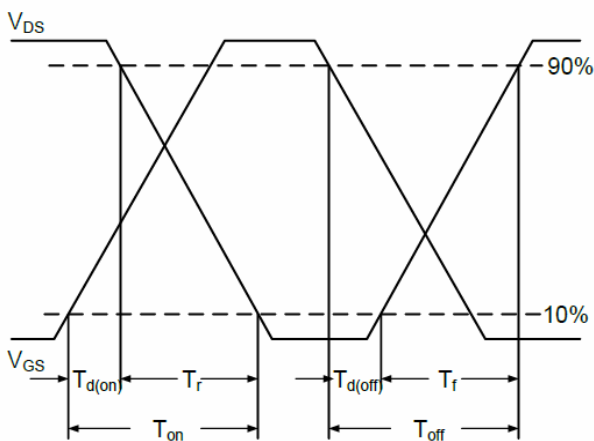


Fig.10 Switching Time Waveform

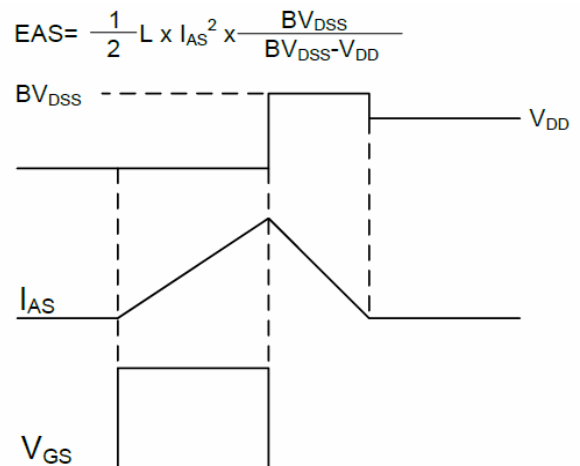


Fig.11 Unclamped Inductive Switching Waveform